



MJ N-Channel Enhancement Mode Power MOSFET

Description

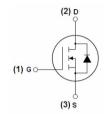
The MJ75H21T uses advanced trench technology and design to provide excellent $R_{\text{DS(ON)}}$ with low gate charge. It can be used in Automotive applications and a wide variety of other applications.

General Features

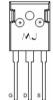
- ♦ V_{DS}=75V,I_D=210A R_{DS(ON)}<4mΩ @ V_{GS}=10V
- ◆ Good stability and uniformity with high Eas
- ◆ Special process technology for high ESD capability
- ◆ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Excellent package for good heat dissipation

Application

- ◆ Automotive applications
- ◆ Hard switched and high frequency circuits
- ◆ Uninterruptible power supply







Marking and pin assignment



TO-247 top view

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ75H21T	MJ75H21T	TO-247	-	-	-

Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vps	75	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	210	А
Drain Current-Continuous(Tc =100℃)	I D(100℃)	150	А
Pulsed Drain Current	Ірм	840	А
Maximum Power Dissipation	Po	330	W
Single pulse avalanche energy (Note 4)	Eas	2200	mJ
Derating factor		2.2	W/°C
Operating Junction and Storage Temperature Range	TJ ,Tstg	-55 To 175	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 1)	RθJA	0.455	°C/W





Electrical Characteristics (T_A =25°Cunless otherwise noted)

Parameter		Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics							
Drain-Source Breakdown Voltage		BVDSS	V _{GS} =0V I _D =250μA	75			V
Zero Gate Voltage Drain Current		loss	V _{DS} =750V,V _{GS} =0V			1	μΑ
Gate-Body Leakage Current		Igss	V _{DS} =±20V,V _{DS} =0V			±200	nA
On Characteristics							
Gate Threshold Voltage		VGS(th)	Vps=Vgs ,Ip=250µA	2	3	4	V
	25℃		Vgs=10V, ID=40A		2.9	4	mΩ
Drain-Source On-State Resistance	125℃	Rds(on)			4.7	6.5	mΩ
Forward Transconductance		grs	V _{DS} =25V,I _D =40A	100	165		S
Dynamic Characteristics							
Input Capacitance		Clss			11000		PF
Output Capacitance		Coss	V _{DS} =25V,V _{GS} =0V, F=1.0MHz		914		PF
Reverse Transfer Capacitance		Crss			695		PF
Switching Characteristics (Note 4)							
Turn-on Delay Time		t _{d(on)}			23		nS
Turn-on Rise Time		tr	V _{DD} =30V,I _D =2A,R _L =15Ω		190		nS
Turn-Off Delay Time		t _{d(off)}	V _{GS} =10V,R _G =2.5Ω		130		nS
Turn-Off Fall Time		tr			120		nS
Total Gate Charge		Qg		-	250		nC
Gate-Source Charge		Qgs	ID=30A, VDD=30V, VGS=10V	-	48		nC
Gate-Drain Charge		Qgd	-	-	98		nC
Drain-Source Diode Characteristics							
Diode Forward Voltage		VsD	V _{GS} =0V,I _S =40A			1.2	V
Reverse Recovery Time		trr	TJ=25°C, IF=40A		48		nS
Reverse Recovery Charge		Qrr	di/dt=100A/µs ^(Note 2)		78		nC
			Intrinsic turn-on time is negligible(turn-on is dominated by L				

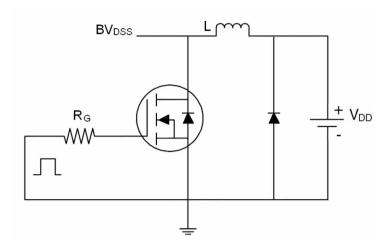
Notes:

- ① Surface Mounted on FR4 Board, t \leq 10sec.
- ② Pulse Test: Pulse Width≤400µs, Duty Cycle≤2%.
- $\begin{tabular}{ll} \hline (3) EAS condition: $T_j=25^\circ C,V_{DD}=37.5V,V_G=10V,L=0.5mH,Rg=25\Omega,I_{AS}=37A$ \\ \hline \end{tabular}$

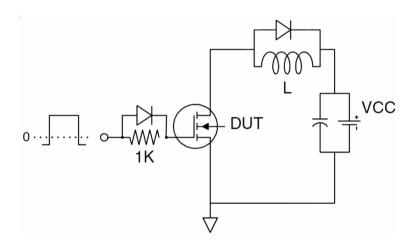




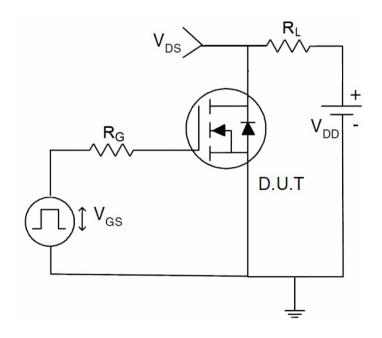
Test circuit



Eas test Circuit



Gate charge test Circuit



Switch Time Test Circuit



le - Drain Current (A)

Typical Electrical and Thermal Characteristics (Curves)

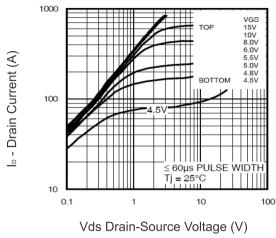


Figure 1 Output Characteristics

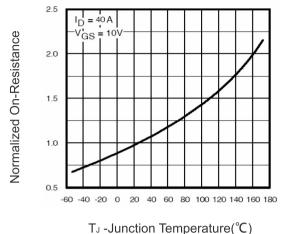


Figure 4 Rdson-Junction Temperature

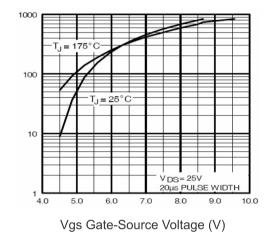


Figure 2 Transfer Characteristics

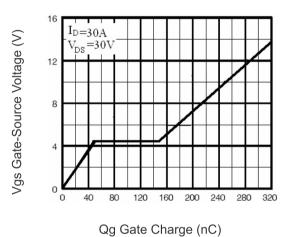


Figure 5 Gate Charge

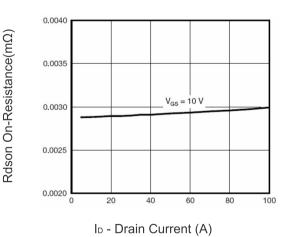


Figure 3 Rdson- Drain Current

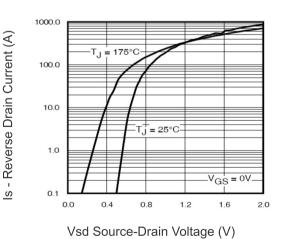
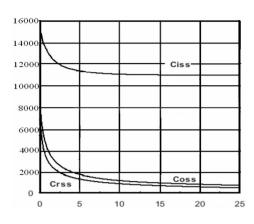


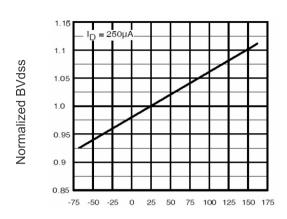
Figure 6 Source- Drain Diode Forward



le - Drain Current (A)



Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)
Figure 9 BVpss vs Junction Temperature

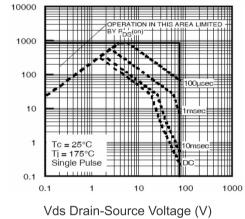


Figure 8 Safe Operation Area

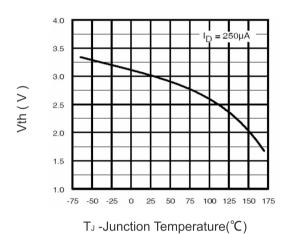
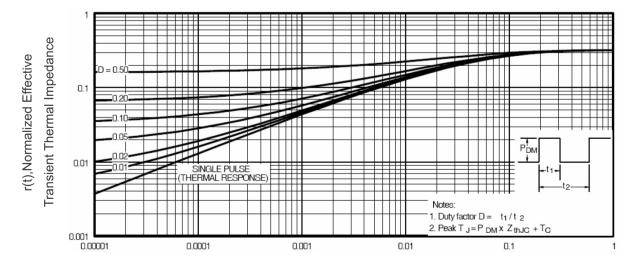


Figure 10 V_{GS(th)} vs Junction Temperature



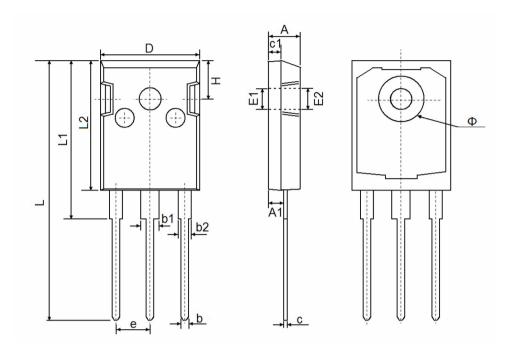
Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance





TO-247 Package Information



Compleal	Dimensions I	In Millimeters	Dimension	s In Inches	
Symbol	Min.	Max.	Min.	Max.	
Α	4.850	5.150	0.191	0.200	
A1	2.200	2.600	0.087	0.102	
b	1.000	1.400	0.039	0.055	
b1	2.800	3.200	0.110	0.126	
b2	1.800	2.200	0.071	0.087	
С	0.500	0.700	0.020	0.028	
c1	1.900	2.100	0.075	0.083	
D	15.450	15.750	0.608	0.620	
E1	3.500 REF		0.138 REF		
E2	3.600 REF		0.142 REF		
L	40.900	41.300	1.610	1.626	
L1	24.800	25.100	0.976	0.988	
L2	20.300	20.600	0.799	0.811	
Ф	7.100	7.300	0.280	0.287	
е	5.450 TYP		0.215 TYP		
Н	5.980 REF		REF 0.235 REF		





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